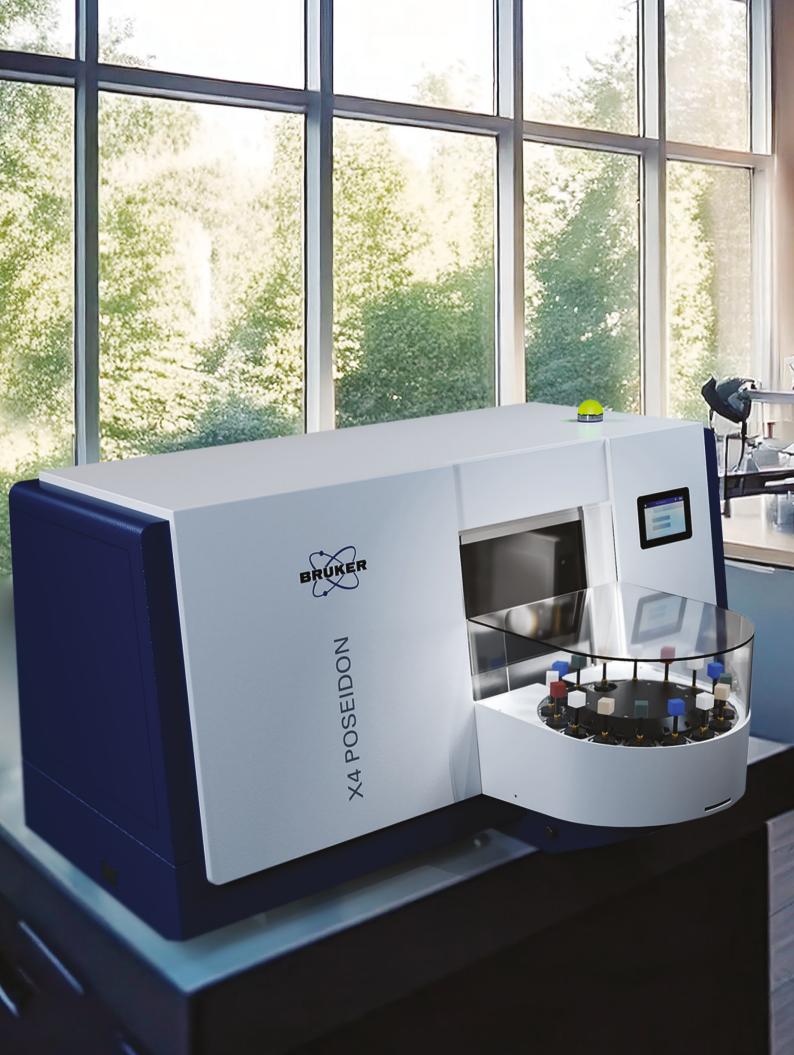




INGENIOUS 3D X-RAY IMAGING X4 POSEIDON

Modular Benchtop Solution

Innovation with Integrity



X4 POSEIDON Modular. Effective. Accessible.

The X4 POSEIDON is the first of its kind, applying the platform design of a floor standing system to a compact benchtop. The **modular** hardware and user-centered software can be tailored to any analytical task.

The X4 POSEIDON is extremely **effective** at balancing Field-of-View, Magnification and Speed. Thanks to flagship technology the instrument resolves 2 μ m features with razor-sharp contrast. Multi-Vision combines two detectors to create the first multi-scale benchtop microscopy solution, while advanced acquisition algorithms and Geometric Magnification Plus (GEM Plus) ensure that every 3D image is optimally collected.

The X4 POSEIDON is an **accessible** walk-up system providing unparallelled ease-of-use with a straightforward workflow, an intuitive user interface, and multi-language support. Requiring only standard power and a lab workbench, the X4 POSEIDON fits into any lab, bringing high quality, non-destructive 3D imaging to everyone, everywhere!

The X4 POSEIDON defines a new class of benchtop X-ray Microscopes.

See What Lies Beneath

No analytical technique is as commonplace as microscopy because seeing is believing. Whether using visible light, electrons or atomically sharp cantilevers, these probes are limited to the surface.

X-Ray Microscopy (XRM), also known as micro-CT is a shift in paradigm, providing a non-destructive three-dimensional view into the microscopic world; giving insight into internal structure and shedding light on the mechanism of failure or confirming successful fabrication.

XRM adds the third dimension to microscopy.



Conventional 2D Microscopy

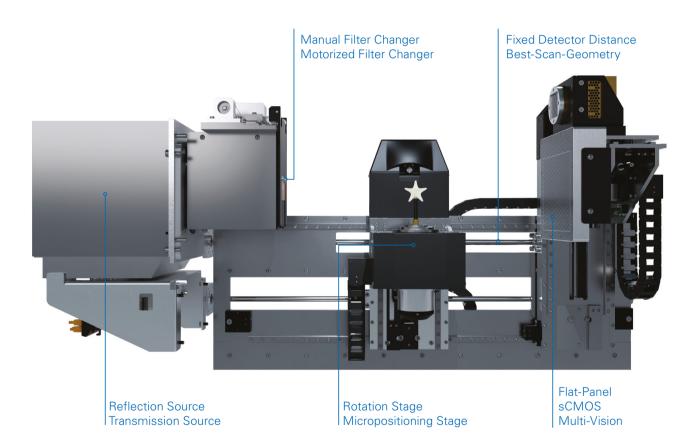


+ INFO See it in action 3D X-ray Microscopy

The Power of a Platform

The challenges of today often justify the acquisition of analytical equipment, but the long-term value comes from being prepared to answer the unanticipated question of tomorrow. The X4 POSEIDON, as configured at the time of purchase, can be reconfigured as needs change and can integrate new components as technology evolves.

Versatile today, Expandable tomorrow

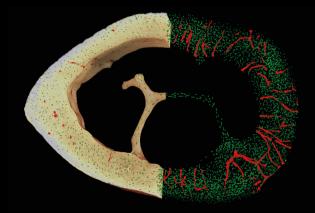


Additional Options

- + Sample Changer
- + Heating Stage
- + Cooling Stage
- + Materials Testing Stage

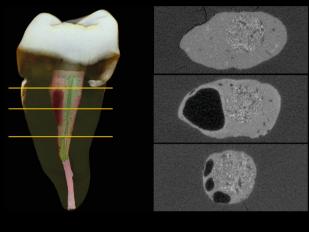
Osteology

3D volume rendering of a mouse femur scanned at a voxel size of 550 nm, partially cut to show the vascular network (red) and osteocyte lacunae (green) in the cortical bone.



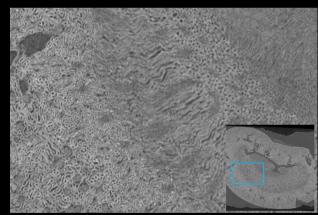
Dentistry

3D volume rendering of a filled human tooth (left) and reconstructed cross-sections (right) showing the filler and voids. The scan was acquired at 4 μ m voxel size using a 16 MP sCMOS detector and sealed transmission X-ray source.



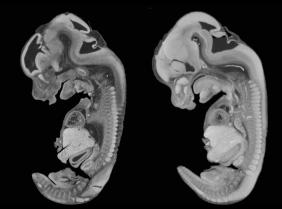
Soft tissues

Phase retrieval cross-section of a mouse kidney, unstained and imbedded in paraffin, scanned at 2.5 μ m. The scan was acquired using a sCMOS detector and a sealed transmission X-ray source.



Embryology

Reconstructed cross-section (left) and maximum intensity projection (right) through a mouse embryo, scanned at 3.7 μm voxel size after contrasting with phosphotunstic acid (PTA).



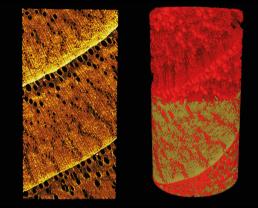
Entomology

3D volume rendering of a genetically modified fruit fly (*Drosophila melanogaster*) showing abnormal eye morphology, 900 nm voxel size. The model is partially cut exposing muscles and internal organs.



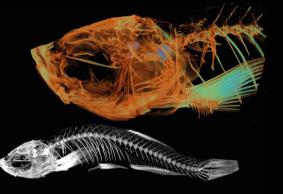
Botany

3D volume rendering of an oak wooden core scanned at a voxel size of 8 μ m, showing segmented vessels. The scan was acquired using a 7 MP flat panel detector and a sealed transmission X-ray source.



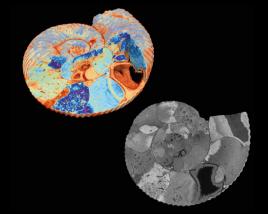
Zoology

3D volume rendering of a zebrafish scanned at a voxel size of 3 μ m, enabling the segmentation of whole skeleton, head and otoliths. The scan was acquired using a 16 MP sCMOS detector and a sealed transmission X-ray source.



Paleontology

3D volume rendering (left) and reconstructed cross-section (right) of a fossil ammonite scanned at a voxel size of 9.6 μ m using the 7 MP flat-panel detector.

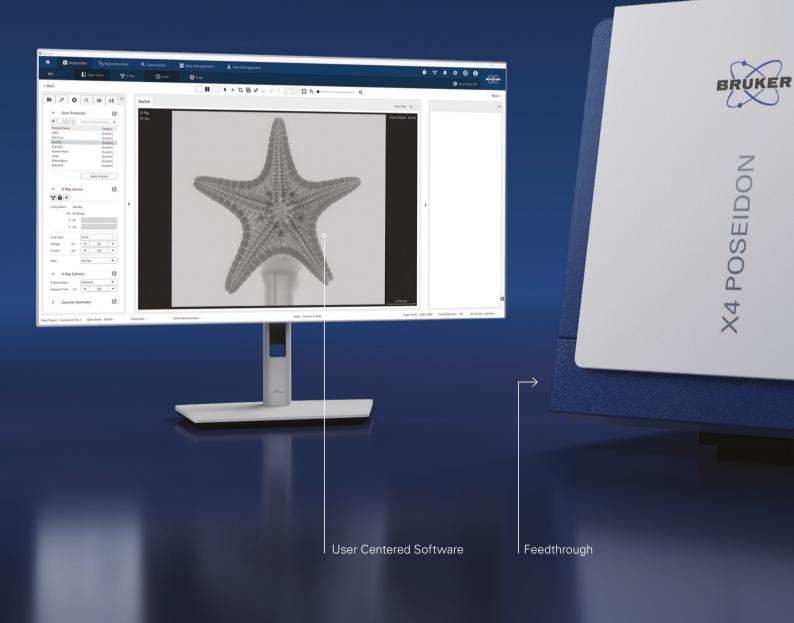


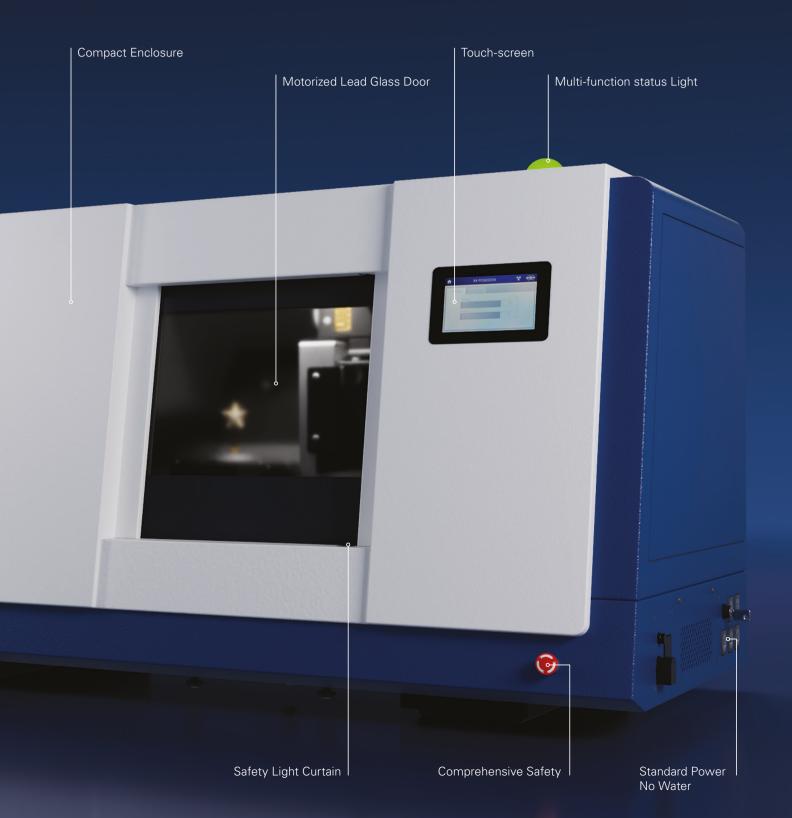


X4 POSEIDON Comprehensive from the Start

The X4 POSEIDON is a comprehensive solution from the start featuring many premium features to enhance the user experience. In its essential configuration the X4 POSEIDON includes a proven reflection X-ray source and versatile flat-panel detector. With these components, the system is capable of ultra-fast scanning with exceptional field-of-view and razor-sharp contrast without compromising resolution.

Whether your lab supports multiple users in diverse research and development fields or a specific industrial process, the X4 POSEIDON offers the full power of non-destructive, qualitative and quantitative 3D analysis.





Bruker's 3D Resolution Guarantee

Every Bruker 3D X-ray Microscopy system comes with the unique 3D resolution guarantee. The 2D and 3D resolution performance is tested and documented with industry standard JIMA 2D and 3D QRM phantoms during factory calibration. After installation, on-site performance is guaranteed by repeating the 3D QRM measurement.

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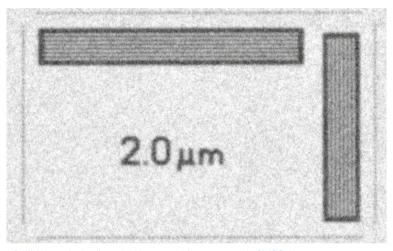
Brilliant X-ray Power

The X4 POSEIDON supports the latest generation of microfocus X-ray sources.

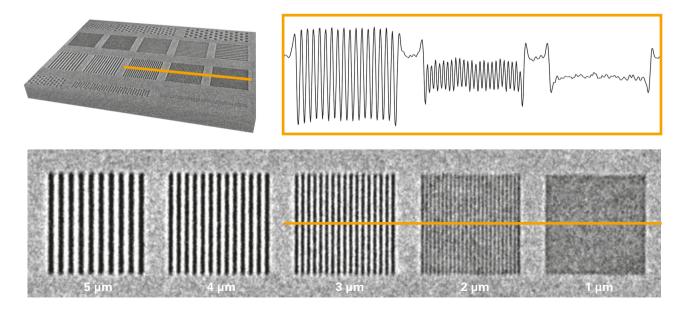
The **reflection X-ray source** produces an X-ray beam with energy up to 100 kV and 20 W power. This industry-grade source is the perfect choice for your workhorse solution in a multi-user facility, service lab or screening environment. It requires no maintenance and feature a low cost of ownership.

The **transmission X-ray source** achieves a 2 μ m spot size and is the perfect research solution to obtain high-resolution data. A maximum energy of 110 kV extends the application range to higher density and larger samples.

The X4 POSEIDON platform allows on-site source exchange as your needs evolve over time.



2D JIMA standard collected with transmission source and sCMOS detector



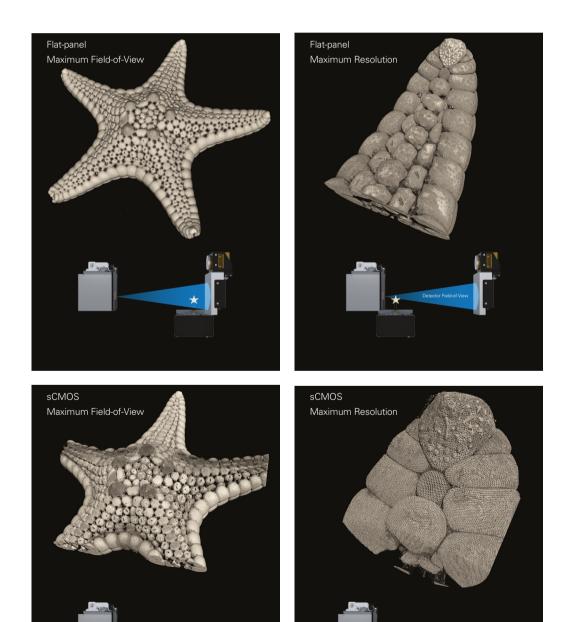
3D QRM standard collected with the transmission source and sCMOS detector. 3D reconstructed volume (top left), extracted slice (bottom) and profile line (top right)

Multi-Vision A Sharp Eye on your Sample

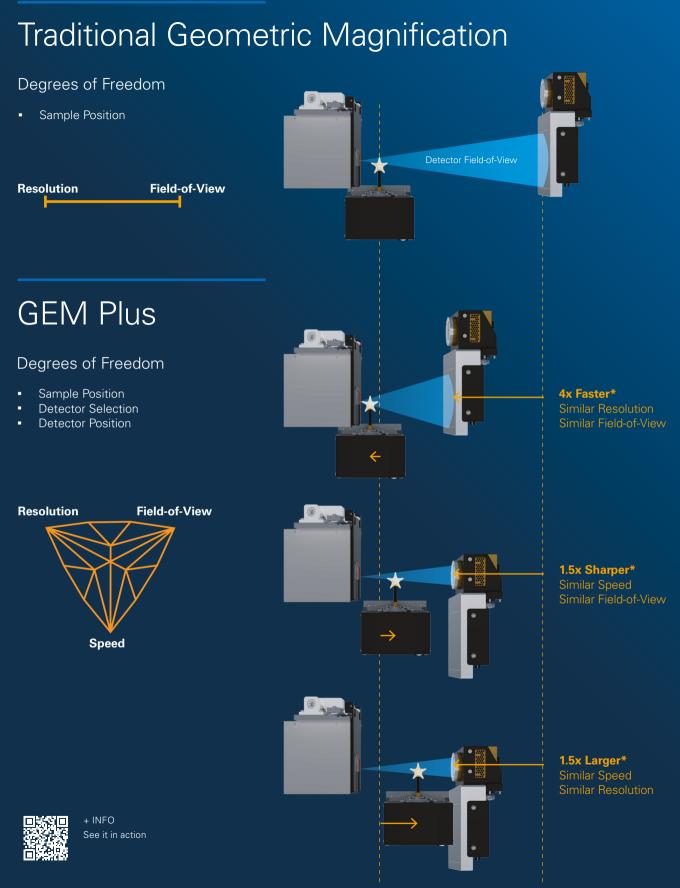
The X4 POSEIDON is the only true multi-detector benchtop microCT solution. It can be equipped with a versatile flat-panel detector, a scientific-grade CMOS detector, or BOTH!

When selecting the ideal detector for your needs, you must consider the balance of field-ofview, resolution and scan speed. If speed is of utmost importance, the flat-panel detector is ideally suited for your application. On the other hand, the sCMOS detector is the ideal choice for maximum resolution. With the X4 POSEIDON a choice does not have to be made. Thanks to Multi-Vision you can have both!

As with the source, the X4 POSEIDON platform allows on-site upgrade to Multi-Vision.







*Compared to Traditional GEM

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GEM Plus Strike the Perfect Balance

By combining Best-Scan-Geometry and Multi-Vision, the X4 POSEIDON delivers ultimate flexibility in a benchtop with Geometric Magnification Plus.

A balance of field-of-view and resolution is achieved by moving the sample closer to the source or closer to the detector. With Best-Scan-Geometry, the detector can also be moved in a continuous way, allowing ideal cone beam utilization for a given sample size while achieving the same magnification ratio resulting in a significant scan speed improvement.

GEM Plus builds on Multi-Vision and Best-Scan-Geometry to strike the perfect balance between pure resolution, scan speed and field-of-view.







Optimize Productivity

The X4 POSEIDON can be upgraded with a 15-position sample changer to maximize instrument usage and minimize operator interaction.

The compact sample changer is ergonomically positioned in front of the instrument. The status of each position is indicated by an LED allowing sample addition or replacement at any time, even during operation. The intelligent loading algorithm (patent pending) optimizes sample throughput.

Each position accommodates samples up to 50 mm diameter and 80 mm height. Small samples can be stacked vertically and bundled to increase capacity.

When not in use, the sample changer can stay installed while having full access to the instrument for loading large samples or specialty stages.

4D microCT Flawlessly Integrated

Enhanced throughput by source power, detector speed efficiency, variable geometry and advanced scanning modes opens new possibilities for in situ 4D experiments using proprietary specialty stages.

The Bruker material testing stages can perform compression and tensile experiments up to 4400 N and 440 N, respectively, while Bruker's heating and cooling stages can reach temperatures of 30 °C below ambient to 80 °C. All stages are integrated into the software and hardware eliminating the need for cables.

A cable feedthrough in the enclosure allows use of custom or third party stages.

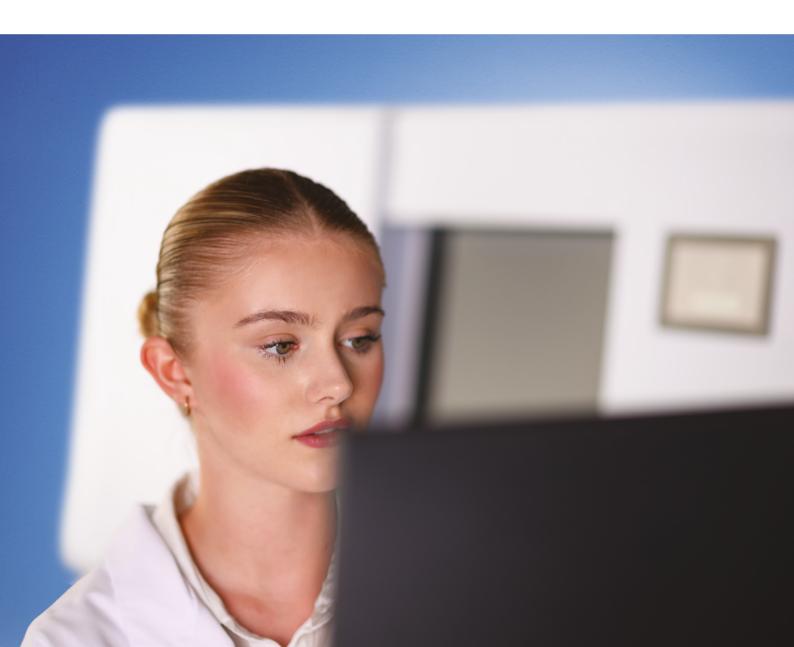


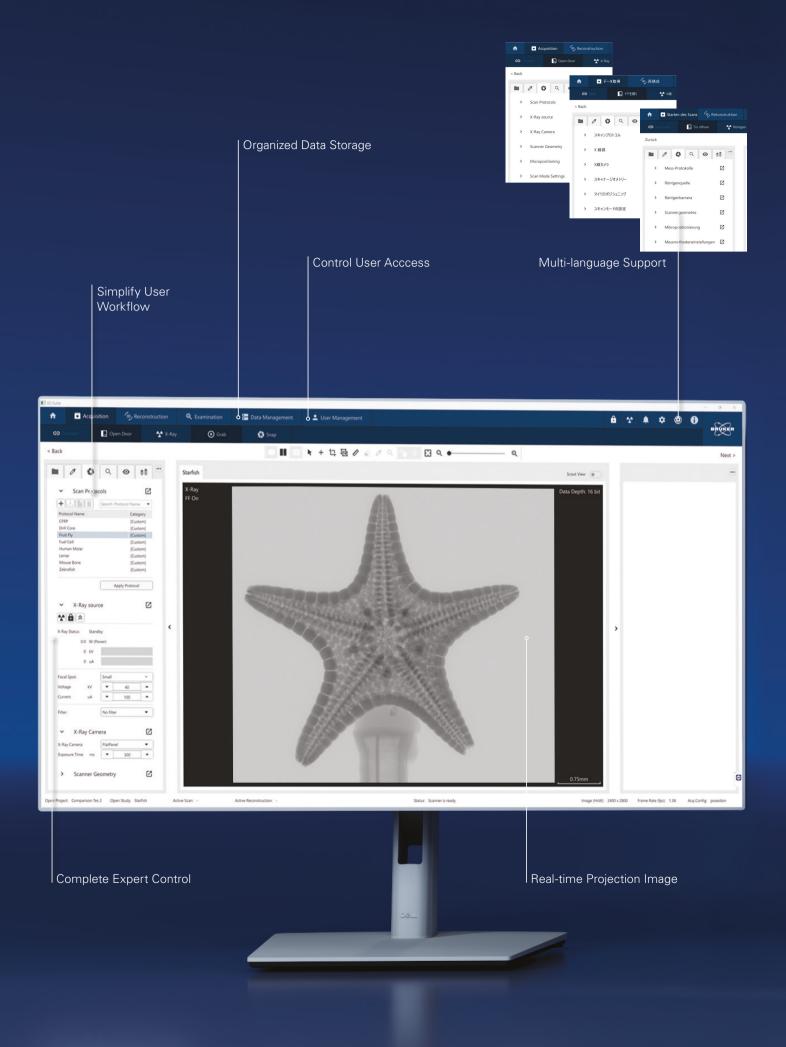
User-centered 3DxSUITE Software

Intuitive, simple, yet powerful – the 3DxSUITE software is designed to inspire finding out what's inside. Its user-centered design ensures even a novice user can easily start imaging.

- Architecture allows easy extension of hard- and software
- User and data management
- Adaptable flexible graphic user interface
- Multi-language support
- Standard includes 3D examination, visualization, and analysis
- Phase retrieval algorithms reveal features that would remain hidden with standard absorption contrast
- Advanced scan algorithms ensure the best image quality

3DxSUITE. The turn-key measurement and analysis solution.





Bruker Imaging Solutions

With over 6 decades of experience designing, building and supporting analytical solutions for routine industrial applications and cutting-edge research, Bruker is the ideal partner for a long-term analytical investment. With a global network of application and service professionals, we are always ready to support your success.

Bruker imaging solutions cover a wide range of technologies including:

- X-ray Microscopy
- Micro X-ray Fluorescence Mapping
- Magnetic Resonance Imaging
- Scanning Transmission Electron Microscopy
- Atomic Force Microscopy

- Raman Microscopy
- Fourier Transform Infrared Microscopy
- Fluorescence Microscopy
- Light Sheet Microscopy
- Molecular Imaging



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